

<b>Notice of References Cited</b>	Application/Control No. 10/627,690		Applicant(s)/Patent Under Reexamination WOZNIAK, ANDRZEJ	
	Examiner Sun J. Lin		Art Unit 2825	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,732,247	03-1998	Dearth et al.	703/13
*	B	US-5,953,707	09-1999	Huang et al.	705/10
*	C	US-2001/0043237 A1	11-2001	Schmieder	345/839
*	D	US-2002/0083402 A1	06-2002	Higashitsutsumi et al.	716/4
*	E	US-6,651,225 B1	11-2003	Lin et al.	716/4
*	F	US-6,578,174 B2	06-2003	Zizzo	716/1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.